

## 1 Scope:

- 1.1 This specification is applicable to lead free, halogen free of RoHS directive for metal alloy low-resistance resistor.
- 1.2 The product is for general purpose.

## 2 Explanation Of Part Numbers:

Type	Size (inch)	Number of Terminals	Rated Power	Resistance (4~6 Digits)	Tolerance	Packaging
Metal Alloy Low Resistance Resistor	• 2512	2: 2 terminals	• 2=2.0W	EX: R005 = 5mΩ R010 = 10mΩ	F=± 1.0%	4=4,000pcs

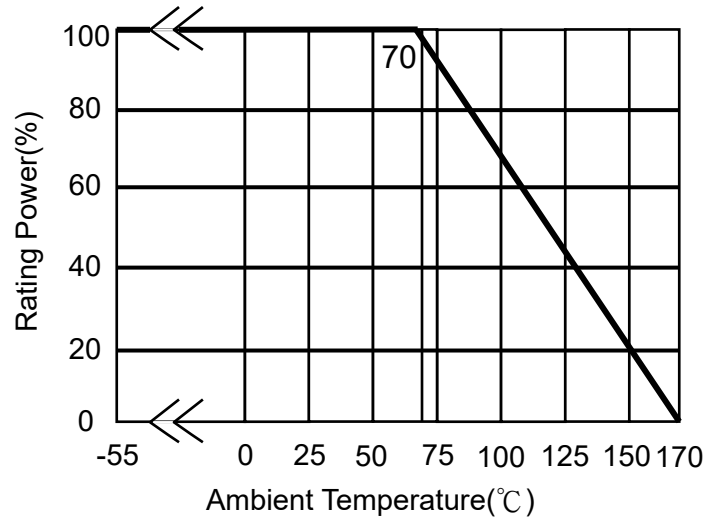
## 3 Product Specifications:

Type	# of Terminals	Rating Power	Rating Current	Overload Current	T.C.R. (ppm/°C)	Resistance Range (mΩ)	Operating Temperature Range
						F (±1%)	
2512	2	2W	$I_r = \sqrt{P/R}$	$I_o = \sqrt{5P/R}$	5mΩ: ≤±50	5mΩ	-55~170°C
					10mΩ: ≤±50	10mΩ	
					15mΩ: ≤±50	15mΩ	
					20mΩ: ≤±50	20mΩ	
					30mΩ: ≤±50	30mΩ	

$I_r$  = Rating Current(A)  
 $I_o$  = Overload Current(A)  
 $P$  = Rating Power(W)  
 $R$  = Resistance(Ω)

### 3.1 Power Derating Curve: Operating Temperature Range : - 55 ~+170 °C

For resistors operated in ambient temperatures 70°C, power rating shall be derated in accordance with the curve below :



### 3.2 Rating Current :

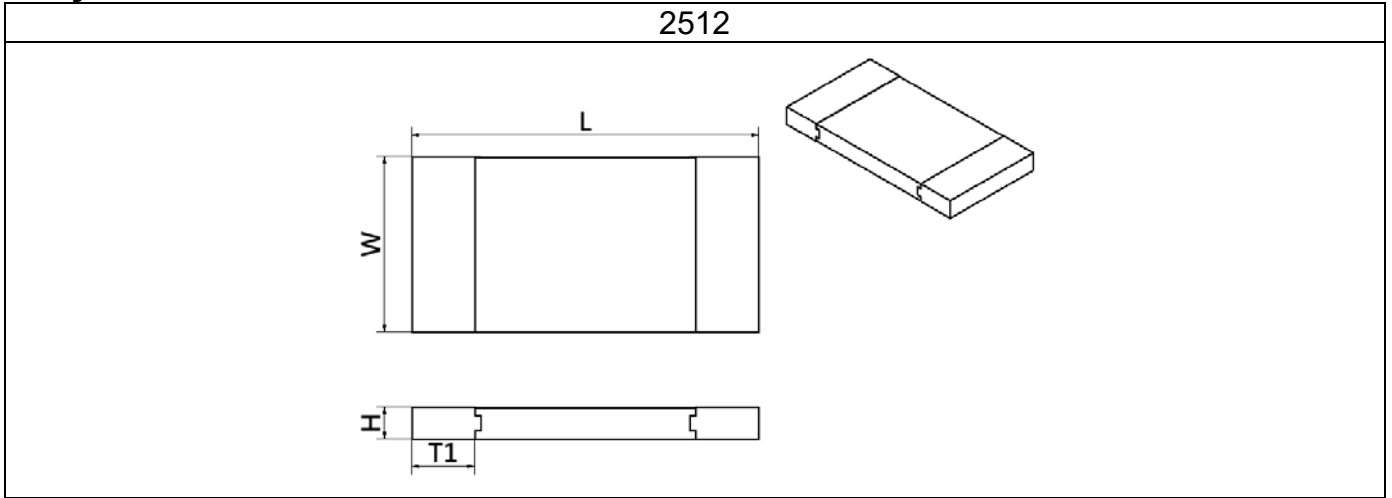
The following equation may be used to determine the DC (Direct Current) or AC (Alternating Current) currents (RMS, root mean square value) of normal rated power. However, if the result value exceeds the highest current of regulated standards, the highest normal rated power is to be used.

Remark:

$$I = \sqrt{P/R}$$

I=Rating Current(A)  
P= Rating Power(W)  
R=Resistance(Ω)

## 4 Physical Dimensions:



Type	Power Rating (Watts)	Resistance Range (mΩ)	Dimensions - in inches (millimeters)			
			L	W	H	T1
2512	2.0	5	0.247±0.010 (6.286±0.254)	0.123±0.010 (3.115±0.254)	0.023±0.010 (0.592±0.254)	0.048±0.010 (1.224±0.254)
		10			0.021±0.010 (0.539±0.254)	
		15				
		20				
		30				

### 4.1 Material of Alloy

Type	Watts	Material	Resistance
2512	2.0	Copper-Manganese Alloy	5mΩ
		Iron-Chromium Aluminum Alloy	10/15/20/30mΩ

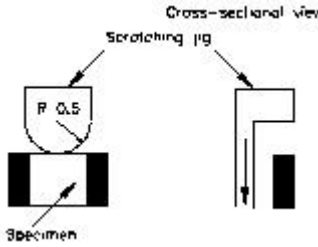
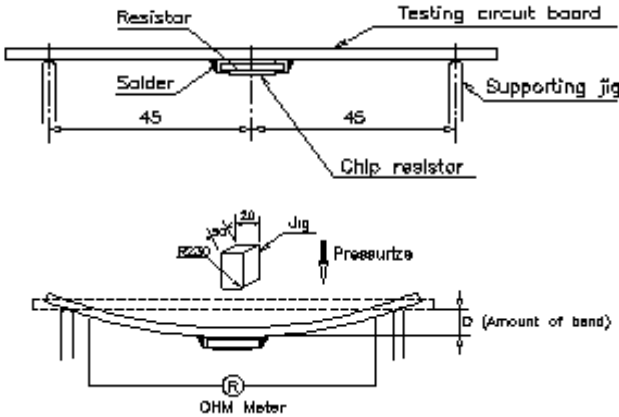
## 5 Reliability Performance:

### 5.1 Electrical Performance :

Test Item	Conditions of Test	Test Limits						
Temperature Coefficient of Resistance (TCR)	$\text{TCR (ppm/}^\circ\text{C)} = \frac{(R2-R1)}{R1 (T2-T1)} \times 10^6$ <ul style="list-style-type: none"> <li>• R1: resistance of room temperature</li> <li>• R2: resistance of 150 °C</li> <li>• T1: Room temperature</li> <li>• T2: Temperature at 150 °C</li> <li>• Refer to JIS C 5201-1 4.8</li> </ul>	Refer to Paragraph 3. general specifications						
Short Time Overload	<p>Applied Overload for 5 seconds and release the load for about 30 minutes, then measure its resistance variance rate. (Overload condition refer to below):</p> <table border="1" style="margin-left: 20px;"> <thead> <tr> <th>Type</th> <th>Power (W)</th> <th># of rated power</th> </tr> </thead> <tbody> <tr> <td>2512</td> <td>2.0</td> <td>5times</td> </tr> </tbody> </table> <p>Refer to JIS C 5201-1 4.13</p>	Type	Power (W)	# of rated power	2512	2.0	5times	≤±0.5%
Type	Power (W)	# of rated power						
2512	2.0	5times						
Insulation Resistance	<p>Put the resistor in the fixture, add 100 VDC in + , - terminal for 60secs then measured the insulation resistance between electrodes and insulating enclosure or between electrodes and base material. Refer to JIS-C5201-1 4.6</p>	≥10 <sup>9</sup> Ω						
Dielectric Withstanding Voltage	<p>Applied 500VAC for 1 minute, and Limit surge current 50 mA (max.) Refer to JIS-C5201-1 4.7</p>	No short or burned on the appearance.						

### 5.2 Mechanical /Constructional Performance :

Test Item	Conditions of Test	Test Limits
Resistance to Solder Heat	<p>The tested resistor be immersed 25 mm/sec into molten solder of 260±5°C for 10±1secs. Then the resistor is left in the room for 1 hour, and measured its resistance variance rate. Refer to JIS-C5201-1 4.18</p>	<p>≤±0.5%</p> <p>No evidence of mechanical damage</p>
Solderability	<p>Add flux into tested resistors, immersion into solder bath in temperature 245±5°C for 3±1sec. Refer to JIS-C5201-1 4.17</p>	Solder coverage over 95%
Core Body Strength	<p>Applied R0.5 test probe at its central part then pushing 5N force on the sample for 10 sec. Refer to JIS-C5201-1 4.15</p>	<p>≤±0.5%</p> <p>No evidence of mechanical damage</p>

Test Item	Conditions of Test	Test Limits
Joint Strength of Solder	<p>Preconditioning                      Put tested resistor in the apparatus of PCT, at a temperature of 105°C, humidity of 100% RH, and pressure of 1.22×10<sup>5</sup> Pa for a duration of 4 hours. Then after left the specimen in a temperature for 2 hours or more.</p> <p>Test method:                      ◎Test item 1 (Adhesion):                      A static load using a R0.5 scratch tool shall be applied on the core of the component and in the direction of the arrow and held for 10 seconds and under load measured its resistance variance rate.                      Load:17.7N</p> <div style="text-align: center;">  <p style="font-size: small;">Cross-sectional view Scratching jig R 0.5 Specimen</p> </div> <p>Refer to JIS-C5201-1 4.32</p>	<p>Test item 1:                      (1). ≤ ±0.5%                      (2). No evidence of mechanical damage.                      No terminal peeling off.</p> <p>Test item 2:                      (1). ≤ ±0.5%                      (2). No evidence of mechanical damage.                      No terminal peeling off and core body cracked.</p>
	<p>◎Test item 2 (Bending Strength):                      Solder tested resistor on to PC board add force in the middle down, and under load measured its resistance variance rate.                      D:2mm</p> <div style="text-align: center;">  <p style="font-size: small;">Resistorbar Testing circuit board Solder 45 45 Supporting jig Chip resistor Jig Pressure OHM Meter D (Amount of bend)</p> </div> <p>Refer to JIS-C5201-1 4.33</p>	

Test Item	Conditions of Test	Test Limits
Resistance to solvent	The tested resistor be immersed into isopropyl alcohol of 20~25°C for 60secs, then the resistor is left in the room for 48 hrs. Refer to JIS-C5201-1 4.29	≤±0.5%
		No evidence of mechanical damage
Vibration	The resistor shall be mounted by its terminal leads to the supporting terminals on the solid table. The entire frequency range :from 10 Hz to 55 Hz and return to 10 Hz, shall be transferred in 1 min. Amplitude : 1.5mm This motion shall be applied for a period of 4 hours in each 3 mutually perpendicular directions (a total of 12hrs) Refer to JIS-C5201-1 4.22	≤ ±0.5%
		No evidence of mechanical damage

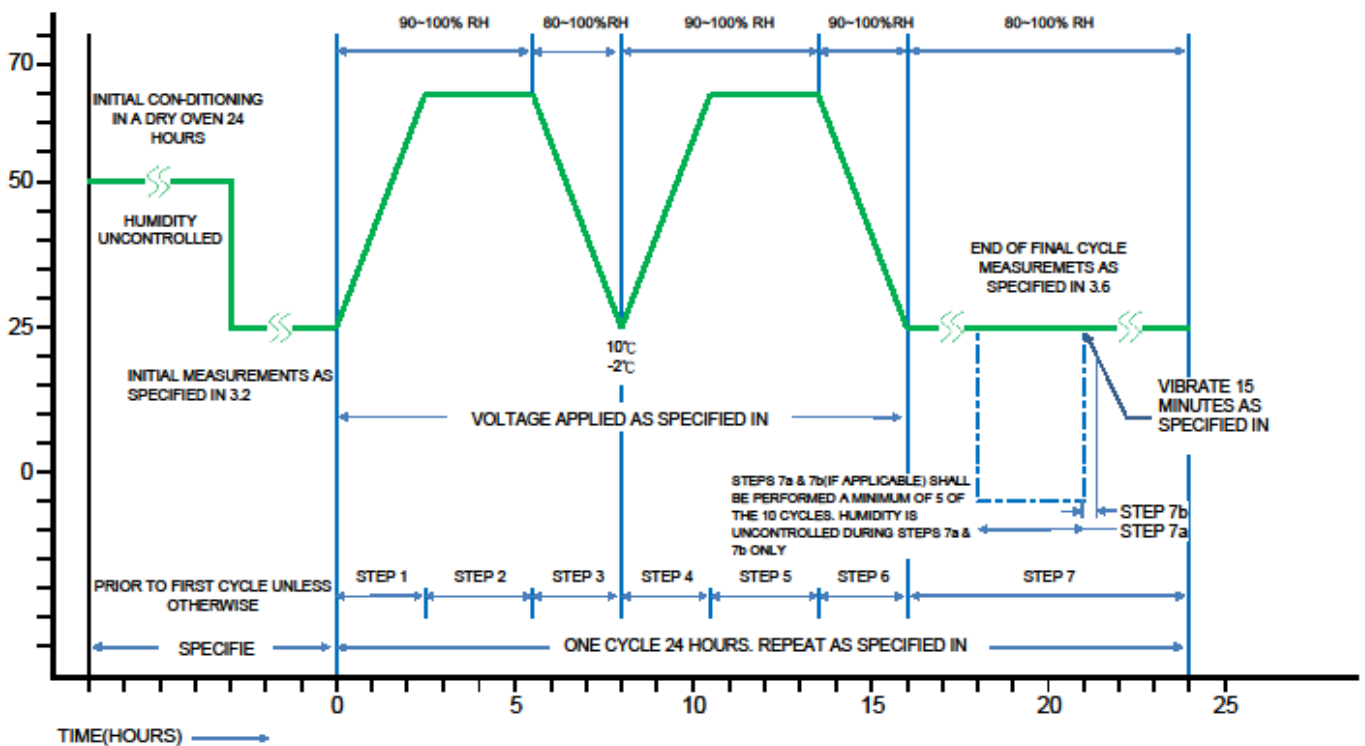
### 5.3 Environmental Performance :

Test Item	Conditions of Test	Test Limits								
Low Temperature Exposure (Storage)	Put the tested resistor in chamber under temperature -55±2°C for 1,000 hours. Then leaving the tested resistor in room temperature for 60 minutes, and measure its resistance variance rate. Refer to JIS-C5201-1 4.23.4	≤±0.5%								
		No evidence of mechanical damage								
High Temperature Exposure (Storage)	Put tested resistor in chamber under temperature 170±5°C for 1,000 hours. Then leaving the tested resistor in room temperature for 60 minutes , and measure its resistance variance rate. Refer to JIS-C5201-1 4.23.2	≤±1.0%								
		No evidence of mechanical damage								
Temperature Cycling (Rapid Temperature Change)	Put the tested resistor in the chamber under the temperature cycling which shown in the following table shall be repeated 300 times consecutively. Then leaving the tested resistor in the room temperature for 60 minutes, and measure its resistance variance rate. <table border="1" style="margin-left: 20px;"> <thead> <tr> <th></th> <th>Testing Condition</th> </tr> </thead> <tbody> <tr> <td>Lowest Temperature</td> <td>-55 +0/-10°C</td> </tr> <tr> <td>Highest Temperature</td> <td>150 +10/-0°C</td> </tr> <tr> <td>Dwell time</td> <td>30min maximum</td> </tr> </tbody> </table> Refer to JESD22-A104		Testing Condition	Lowest Temperature	-55 +0/-10°C	Highest Temperature	150 +10/-0°C	Dwell time	30min maximum	≤ ±1.0
			Testing Condition							
Lowest Temperature	-55 +0/-10°C									
Highest Temperature	150 +10/-0°C									
Dwell time	30min maximum									
		No evidence of mechanical damage								
Moisture Resistance (Climatic Sequence)	Put the tested resistor in chamber and subject to 10 cycles of damp heat and without power. Each one of which consists of the steps 1 to 7 (Figure 1). Then leaving the tested resistor in room temperature for 24 hr, and measure its resistance variance rate. Refer to MIL-STD 202 Method 106	≤±0.5%								
		No evidence of mechanical damage								
Bias Humidity	Put the tested resistor in chamber under 85± 5°C and 85± 5%RH with 10% bias and load the rated current for 90 minutes on, 30 minutes off, total 1,000 hours. Then leaving the tested resistor in room temperature for 60 minutes, and measure its resistance variance rate. Refer to JIS-C5201-1 4.24	≤±0.5%								
		No evidence of mechanical damage								

Test Item	Conditions of Test	Test Limits										
Whisker Test	◎Test item (Thermal Shock test): <table border="1" style="margin-left: 20px;"> <thead> <tr> <th colspan="2">Testing Condition</th> </tr> </thead> <tbody> <tr> <td>Minimum storage temperature</td> <td>-55+0/-10°C</td> </tr> <tr> <td>Maximum storage temperature</td> <td>85+10/-0°C</td> </tr> <tr> <td>Temperature-retaining time</td> <td>10 min.</td> </tr> <tr> <td>Number of temperature cycles</td> <td>1,500</td> </tr> </tbody> </table>	Testing Condition		Minimum storage temperature	-55+0/-10°C	Maximum storage temperature	85+10/-0°C	Temperature-retaining time	10 min.	Number of temperature cycles	1,500	Max. 50 μm
	Testing Condition											
Minimum storage temperature	-55+0/-10°C											
Maximum storage temperature	85+10/-0°C											
Temperature-retaining time	10 min.											
Number of temperature cycles	1,500											
◎Inspection: Inspect for whisker formation on specimens that underwent the acceleration test specified in subclause 4.2, with a magnifier (stereo microscope) of about 40 or higher magnification. If judgment is hard in this method, use a scanning electron microscope (SEM) of about 1,000 or higher magnification. By JESD Standard NO.22A121 class 2.												

### 5.4 Operational Life Endurance:

Test Item	Conditions of Test	Test Limits
Load Life	Put the tested resistor in chamber under temperature 70± 2°C and load the rated current for 90 minutes on 30 minutes off, total 1000 hours. Then leaving the tested resistor in room temperature for 60 minutes, and measure its resistance variance rate. Refer to JIS-C5201-1 4.25	≤±1.0%
		No evidence of mechanical damage



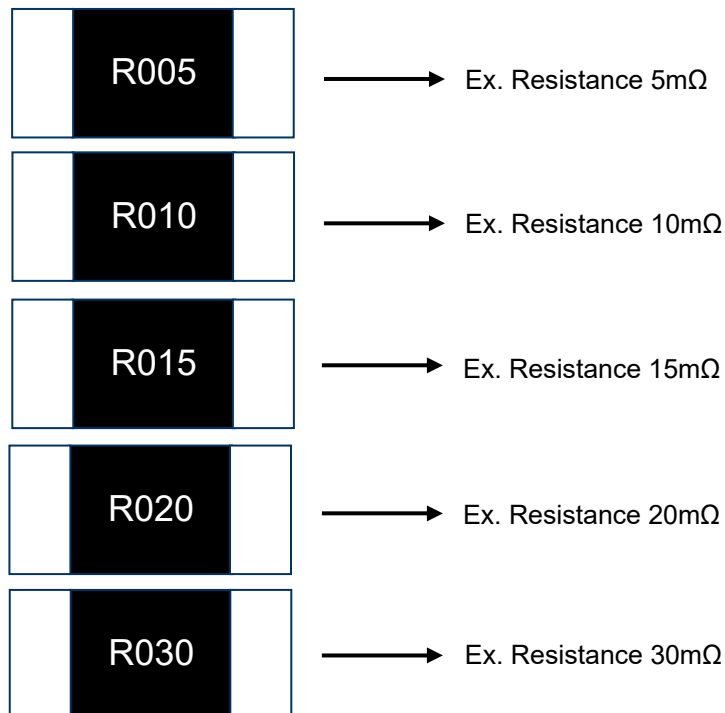
## 6 Marking Format:

6.1 Product resistance is indicated by using two marking notation styles:

“R” designates the decimal location in ohms, e.g.







- For 5mΩ the product marking is R005;
- For 10mΩ the product marking is R010;

6.2 2512 Series (4-digits marking)





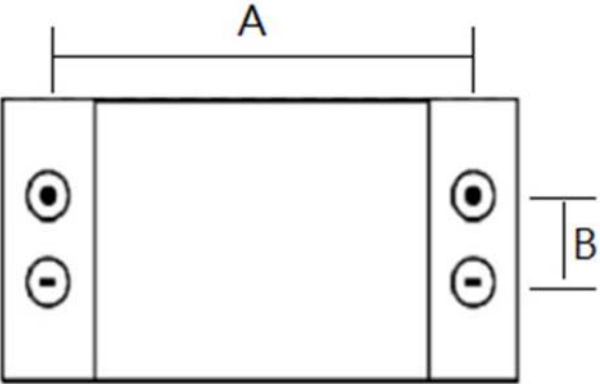
### 6.3 Marking Style:

Marking Type	R	1	2	3	5	0
2512						

### 7 Plating Thickness:

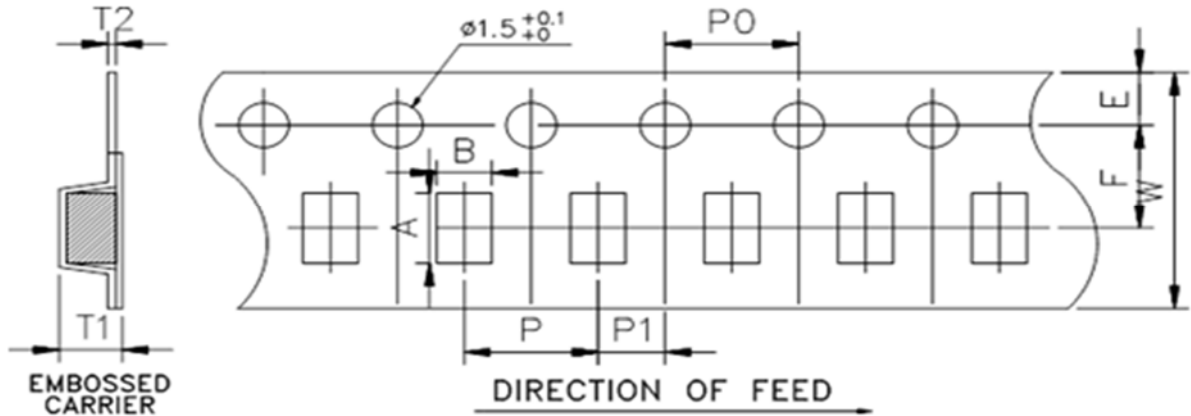
- 7.1 Ni $\geq$ 2 $\mu$ m
- 7.2 Sn(Tin) $\geq$ 3 $\mu$ m
- 7.3 Sn(Tin):Matte Sn

### 8 MEASURE POINT:

Bottom Side	Type	A	B
	ACMP2512	$5.35\pm 0.25$	$1.80\pm 0.25$
Unit : mm			

## 9 Taping specification

### 9.1 Tape Dimensions :



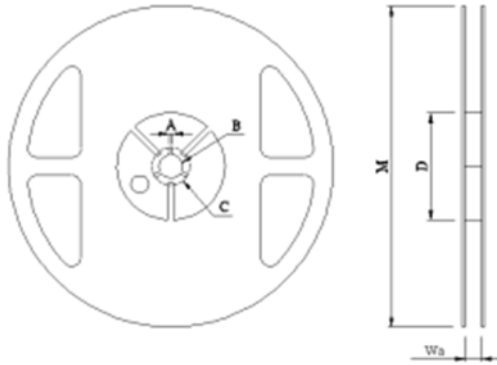
Unit: mm

DIM Item	A	B	W	E	F	T1	T2	P	P0	10*P0	P1
2512	6.75±0.10	3.50±0.10	12.0±0.15	1.75±0.10	5.5±0.10	1.30±0.10	0.20±0.05	4.0±0.10	4.0±0.10	40.0±0.20	2.0±0.10

### 9.2 Packaging model :

Type	Tape width	Max. Packaging Quantity (pcs/reel)
		Embossed Plastic Type
2512	12mm	4mm pitch 4,000pcs

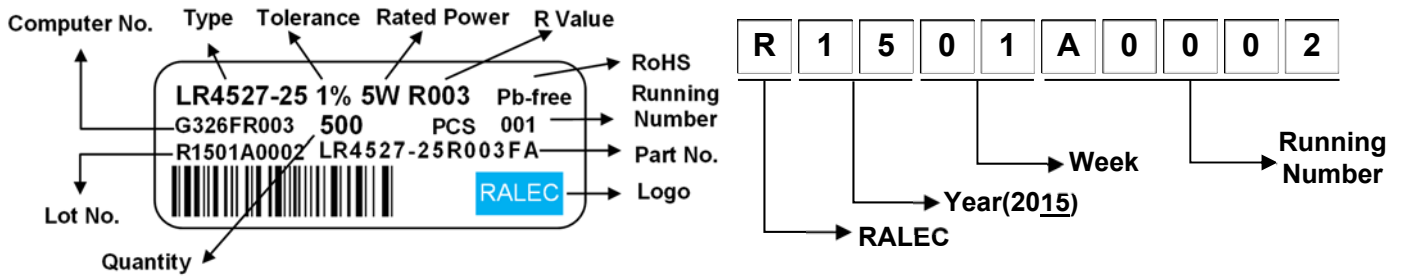
### 9.3 Reel Dimensions :



單位: mm

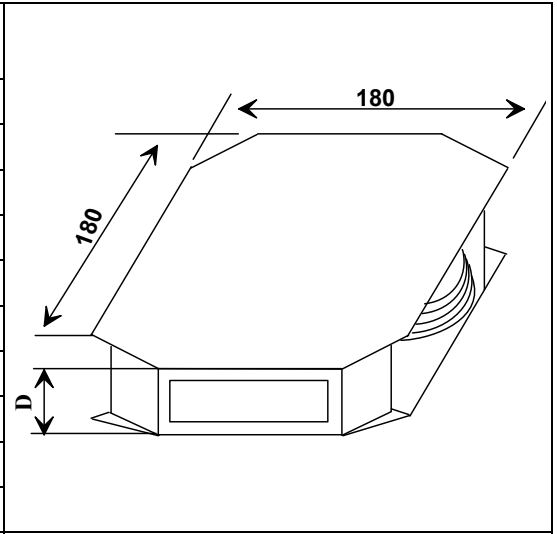
Reel Type / Tape	W	M	A	B	C	D
7" reel for 12 mm tape	13.8 ± 0.5	178 ± 2.0	2.0 ± 0.5	13.5 ± 0.5	21.0 ± 0.5	80.0 ± 1.0

### 9.4 Label :



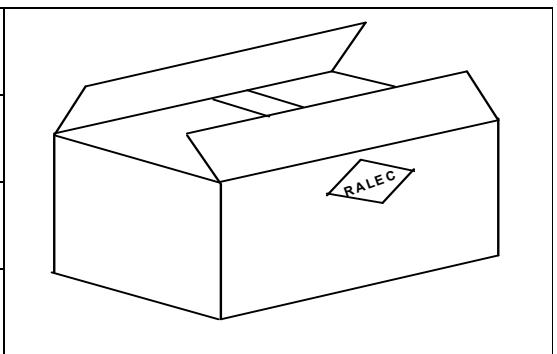
### 9.5 Inner Box :

Reel Number (for 8 mm tape)	Reel Number ( for 12 mm tape)	Reel Number ( for 24 mm tape)	D Dimension (mm)
1	-	-	12
2	1	-	24
3	2	1	36
4	-	-	48
5	3	2	60
6	4	-	72
7	-	3	84
8	-	-	96
9	-	-	108
10	-	4	120



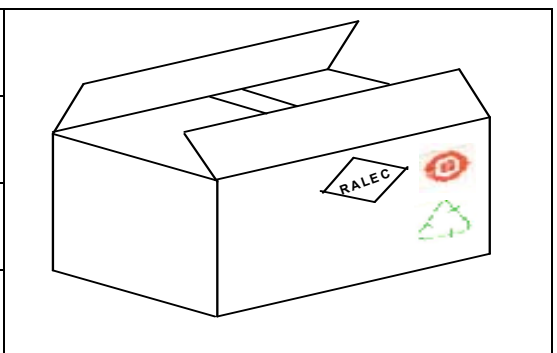
### 9.6 Box :

10R Inner Box Number	L(mm)	W(mm)	D(mm)
2	272	205	210
4	375	280	210
8	544	380	210



### 9.7 Box(For China) :

10R Inner Box Number	L(mm)	W(mm)	D(mm)
2	272	205	210
4	375	280	210
8	544	380	210

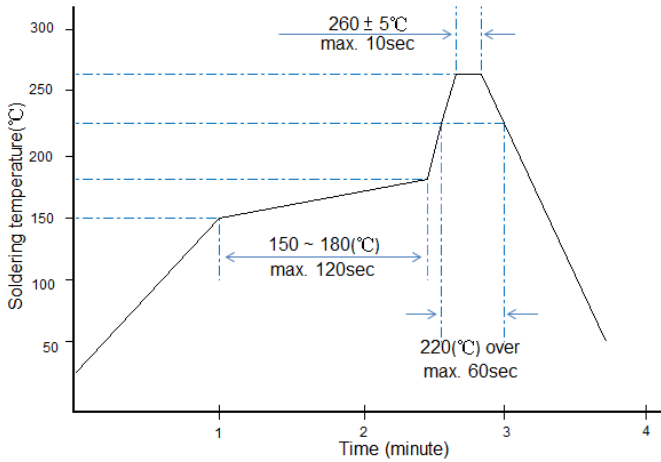


## 10 Technical note (This is for recommendation, please customer perform adjustment according to actual application)

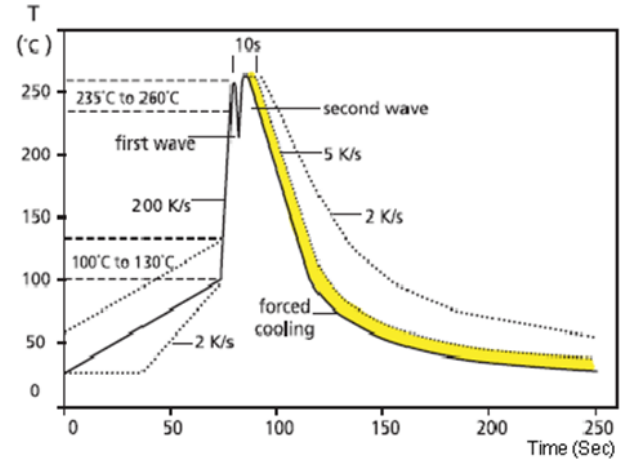
### 10.1 Recommend Soldering Method:

10.1.1 Surface-mount components are tested for solderability at a temperature of 245 °C for 3 seconds.

10.1.2 Typical examples of soldering processes that provide reliable joints without any damage are given in below:



Recommended IR Reflow Soldering Profile  
MEET J-STD-020D

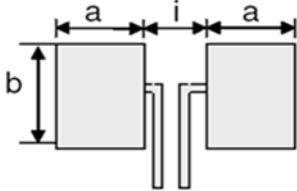


Recommended double-wave Soldering Profile  
Typical values (solid line)  
Process limits (dotted line)

10.1.3 Soldering Iron: temperature 350°C ± 10°C, dwell time shall be less than 3 sec.

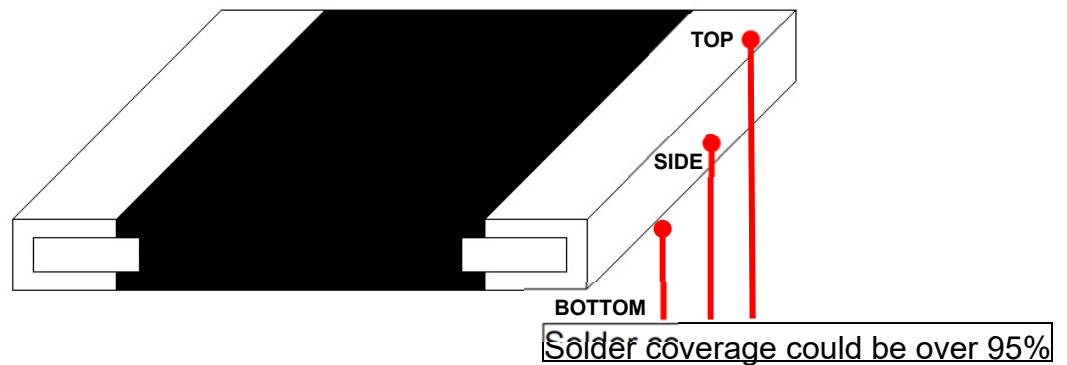
## 10.2 Recommend Land Pattern:

When a component is soldered, the resistance after soldering changes slightly depending on the size of the soldering area and the amount of soldering. When designing a circuit, it is necessary to consider the effect of a decrease or increase in its resistance.



Type	Maximum Power Rating (Watts)	Resistance Range (mΩ)	Dimensions - in millimeters		
			a	b	i
	2.0	5	2.11	3.68	3.18
		10			
		15			
		20			
		30			

## 10.3 Product warranted solder area



## 10.4 The characteristic of Fe/Cr/Al alloy material:

Because of including magnetism, inductor will be generated under high frequency circuit then to cause value shift and influence customer application. If there is related application shall be noted especially or discuss with original factory.

## 10.5 Environment Precautions:

This specification product is for general electronic use, RALEC will not be responsible for any damage, cost or loss caused by using this specification product in any special environment. If other applications need to confirm with RALEC.

If consumer intends to use our Company product in special environment or condition (including but not limited to those mentioned below), then will need to make individual recognition of product features and reliability accordingly.

- (a) Used in high temperature and humidity environment
- (b) Exposed to sea breeze or other corrosive gas, such as Cl<sub>2</sub>、H<sub>2</sub>S、NH<sub>3</sub>、SO<sub>2</sub> and NO<sub>2</sub>.
- (c) Used in non-verified liquids including water, oil, chemical and organic solvents.
- (d) Using non-verified resin or other coating material to seal or coat our Company product.
- (e) After soldering, it is necessary to use water-soluble detergents to clean residual solder fluxes, even though no-clean fluxes are recommended.

## 10.6 Momentary Overload Precautions:

The product might be out of function when momentary overloaded. Please make sure to avoid momentary overloading while using and preserving ◦

## 10.7 Operation and Processing Precautions:

- (a) Avoid damage to the edge of resistor and protective layer caused by mechanical stress.
- (b) Handle with care when printing circuit board (PCB) is divided or fixed on support body, because bending of printing circuit board (PCB) mounting will make mechanical stress for resistors.
- (c) Make sure the power rating is under the limit when using the resistor. When power rating is over the limit, the resistor will be overloaded. There might be machinery damage due to the climbing temperature.
- (d) If the resistor will be exposed under massive impact load (shock wave) in a short period of time, the working environment must be set up well before use.
- (e) Please make evaluation and confirmation when the product is well used in your company and have a through consideration of it's fail-safe design to ensure the system safety.

## 11 Storage and Transportation requirement:

- 11.1 The temperature condition must be controlled at  $25\pm 5^{\circ}\text{C}$ , the R.H. must be controlled at  $60\pm 15\%$ . The stock can maintain quality level in two years.
- 11.2 Please avoid the mentioned harsh environment below when storing to ensure product performance and its' weldability. Places exposed to sea breeze or other corrosive gas, such as  $\text{Cl}_2$ 、 $\text{H}_2\text{S}$ 、 $\text{NH}_3$ 、 $\text{SO}_2$  and  $\text{NO}_2$ .
- 11.3 When the product is moved and stored, please ensure the correct orientation of the box. Do not drop or squeeze the box. Otherwise, the electrode or the body of the product may be damaged.

## 12 Attachments

- 12.1 Document Revise Record (QA-QR-027)



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